# EMI Common Mode Choke Automotive Grade AWCU Series





#### Overview

An EMI common mode choke (CMC) for power lines is a passive component specifically designed to suppress electromagnetic interference (EMI) in power supply circuits

A full series of common mode choke is designed for excellent noise attenuation with compact sizing for use in wide range of applications. Both standard series and custom designs are available.

#### **Benefits**

- 1. Automotive signal Line Common Mode Filter
- 2. Automotive CAN Bus Systems
- 3. Designed according the IEEE802.3 and IEC6228-3 standard
- 4. Operating temperature range −50°C ~ 150°C

#### **Applications**

- 1. Automotive CAN Bus Systems
- 2. EMI solutions for charger
- 3. LVDS
- 4. Networking

#### **Product Information**

Series	Size Code (JIS/EIA)	Impedance(Ω)
AWCU	2012/0805 3216/1206	30 ~ 6500
	3325/1210	
	4532/1812	

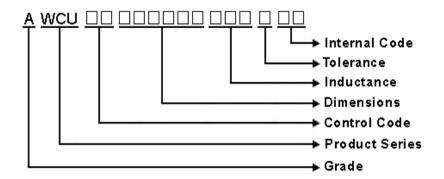






AEC-Q200

- 1 Scope: This specification applies to AWCU Wire Wound Common Mode Choke Coil
- 2 Part Numbering:



3 Rating:

Operating Temperature:  $-50^{\circ}$ C ~  $150^{\circ}$ C

(Including self - temperature rise)

Storage Temperature:  $-40^{\circ}$ C ~ 125 $^{\circ}$ C

(The storage temperature range is for after the assembly)

4 Marking:

No Marking

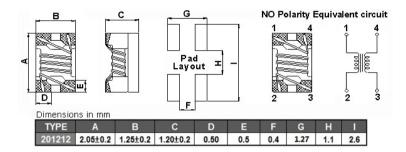
### 5 Standard Testing Condition

Unless otherwise specified In case of dou		
Temperature	Ordinary Temperature(15 to 35℃)	20 to 30°C
Humidity	Ordinary Humidity(25 to 85% RH)	50 to 80 %RH



AEC-Q200

# 6 Configuration and Dimensions and Unit Weight:



Net Weight (grms)	
SIZE CODE	Net Weight (grms)
201212	0.0129 (typ.)

### 7 Electrical Characteristics:

Part No.	Z (Ω)	RDC (Ω)Max.	IDC (mA)	Rated Voltage (Vdc)	Withstandin g Voltage (Vdc)	Insulation Resistance (MΩ)(min)	Tolerance (±%)	Test Freq. (MHz)
AWCU00201212300 = 02	30	0.2	450	50	125	10	20,25	100
AWCU00201212670□02	67	0.25	400	50	125	10	20,25	100
AWCU00201212750□02	75	0.3	360	50	125	10	20,25	100
AWCU00201212900□02	90	0.35	330	50	125	10	20,25	100
AWCU00201212121□02	120	0.3	400	50	125	10	20,25	100
AWCU00201212161□02	160	0.35	350	50	125	10	20,25	100
AWCU00201212181□02	180	0.35	330	50	125	10	20,25	100
AWCU00201212201□02	200	0.35	330	50	125	10	20,25	100
AWCU00201212221 02	220	0.35	310	50	125	10	20,25	100
AWCU00201212261 02	260	0.4	300	50	125	10	20,25	100
AWCU00201212301 02	300	0.4	290	50	125	10	20,25	100
AWCU00201212361 02	360	0.45	280	50	125	10	20,25	100
AWCU00201212371 02	370	0.45	280	50	125	10	20,25	100
AWCU00201212391□02	390	0.45	280	50	125	10	20,25	100
AWCU00201212491 02	490	0.55	170	50	125	10	20,25	100
AWCU00201212501□02	500	0.55	170	50	125	10	20,25	100
AWCU00201212671□02	670	0.6	140	50	125	10	20,25	100
AWCU00201212801□02	800	0.88	300	50	125	10	20,25	100
AWCU00201212901□02	900	0.6	80	50	125	10	20,25	100
AWCU00201212921□02	920	0.75	80	50	125	10	20,25	100
AWCU00201212102□02	1000	0.8	150	50	125	10	20,25	100
AWCU00201212202 = 02	2000	2.2	150	50	125	10	20,25	100

NOTE: □-tolerance M=±20% Y=±25%

<sup>1.</sup>Operating temperature range  $\,$  -  $\,$  5 0 °C  $\sim$  1 5 0 °C(Including self - temperature rise)

<sup>2.</sup>RDC: SINGLE WIRE TEST VALUE

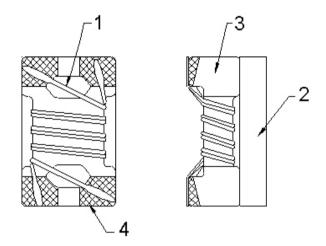
<sup>3.</sup>IDC for Inductance drop 10% from its value without current.

<sup>4.</sup>weight: 0.0129(g)typ.



AEC-Q200

# 8 AWCU00201212 Series 8.1 Construction:



#### 8.2 Material List:

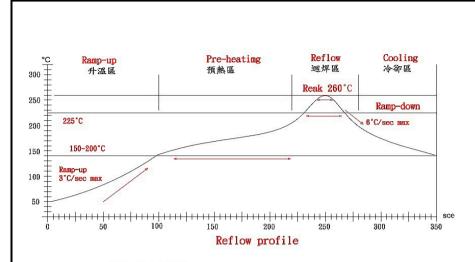
ITEM	PART	DESCRIPTION	
1	WIRE	Grade 180	
2	COVER SHEET	FERRITE CORE	
3	CORE	FERRITE CORE	
4	TERMINAL	Ag/Cu/Ni/Sn	





	lechanical Performa		Tank 88-41 J
	Item	Specification	Test Method
1	Board Flex		Test device shall be soldered on the substrate
		· ·	Substrate Dimension: 100x40x1.6mm
		the terminal electrode and the	Deflection: 2.0mm
		ferrite.	Keeping Time: 60 sec
			l <del>- 45</del>
-2	Terminal Strength	The chip must not damage the	Appendix 1 Note(AEC-Q200-005):Force of 2Lbs for 60
	_	terminal electrode and the	seconds.
		ferrite.	
-3	Solderability	The electrodes shall be at	Pre-heating: 150°ℂ, 1min
Ŭ	o o a o a o a o a o a o a o a o a o a o	least 95% covered with new	Solder Composition: Sn/3.0Ag/0.5Cu
		solder coating.	Solder Temperature: 245±5°C
		Solder coating.	Immersion Time: 4±1sec
			IIIIIIersion Time. 4115ec
1	Resistance to	Appearance:No damage	Due handings 450°C Amin
-4		• • • • • • • • • • • • • • • • • • • •	Pre-heating: 150°C, 1min
	Soldering Heat	Inductance change shall	Solder Composition: Sn/Ag3.0/Cu0.5
		be within ±20%.	Solder Temperature: 260±5°C
			Immersion Time: 10±1sec
	Resistance to		
1-5	Solvents	There must be no change in	Inductors must withstand 6 minutes of alcohol or water.
	231701110	appearance or obliteration of	
		marking.	
	Mechanical Shock	· ·	Dulas shape t Half sin
σ-ι	IVIECTIATIICAI SNOCK		Pulse shape: Half-sine waveform
		_	Impact acceleration: 100 g
		the terminal electrode and the	
		ferrite.	Number of shocks: 18 shocks (3 shocks for each face)
			Orientation: Bottom, top, left, right, front and rear faces
-7	Vibration	Appearance:No damage	Vibration waveform: Sine waveform
		Inductance change shall be	Vibration frequency: 10Hz~2000Hz
		within ±20%.	Vibration acceleration: 5g
			Sweep rate: 0.764386otcave/minute
			·
			Duration of test: 12 cycles each of 3 orientations
			·
2.E	nvironmental Perfo	rmance	Duration of test: 12 cycles each of 3 orientations 20 minutes for each cycle Vibration axes: X, Y & Z
О	Item	Specification	Duration of test: 12 cycles each of 3 orientations 20 minutes for each cycle Vibration axes: X, Y & Z  Test Method
О	Item High Temperature	Specification Appearance:No damage (for	Duration of test: 12 cycles each of 3 orientations 20 minutes for each cycle Vibration axes: X, Y & Z  Test Method  Temperature: 150±3°C
0	Item	Specification Appearance:No damage (for microscope of CASTOR MZ-4	Duration of test: 12 cycles each of 3 orientations 20 minutes for each cycle Vibration axes: X, Y & Z  Test Method  Temperature: 150±3°C  Time: 1000hrs
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2-1 2-2 2-3	Item High Temperature Exposure (Storage)  Low Temperature Exposure (Storage)  Operational Life  Biased Humidity  Temperature Cycling	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Duration of test: 12 cycles each of 3 orientations 20 minutes for each cycle Vibration axes: X, Y & Z  Test Method  Temperature: 150±3°C Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Temperature: -50±3°C Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Temperature: 125±2°C  Appliend Current: Rated Current Time: 1000± 24 hrs  Measured after exposure in the room condition for 24hrs  Temperature: 85±2°C  Relative Humidity: 85% Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C  Soak Mode Condition: 30 minutes  Measured after exposure in the room condition for 24hrs  Test mode: Contact Discharge  Discharge level: ±6KV, Discharge interval: 1 second  Polarity of the output voltage: Positive and negative  Number of discharge: Discharge  Discharge: Let Discharge interval: 1 time for the 2 test points.  Test Mode: Air Discharge
2-1 2-2 2-3	Item High Temperature Exposure (Storage)  Low Temperature Exposure (Storage)  Operational Life  Biased Humidity  Temperature Cycling	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Duration of test: 12 cycles each of 3 orientations 20 minutes for each cycle Vibration axes: X, Y & Z  Test Method  Temperature: 150±3°C Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Temperature: -50±3°C Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Temperature: 125±2°C  Appliend Current: Rated Current Time: 1000± 24 hrs  Measured after exposure in the room condition for 24hrs  Temperature: 85±2°C  Relative Humidity: 85% Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C  Soak Mode Condition: 30 minutes  Measured after exposure in the room condition for 24hrs  Test mode: Contact Discharge  Discharge level: ±6KV, Discharge interval: 1 second  Polarity of the output voltage: Positive and negative  Number of discharge: Discharge  Discharge level: ±12KV, ±16KV, ±25KV
2-1 2-2 2-3 2-4	Item High Temperature Exposure (Storage)  Low Temperature Exposure (Storage)  Operational Life  Biased Humidity  Temperature Cycling	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Duration of test: 12 cycles each of 3 orientations 20 minutes for each cycle Vibration axes: X, Y & Z  Test Method  Temperature: 150±3°C Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Temperature: -50±3°C Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Temperature: 125±2°C Appliend Current: Rated Current Time: 1000± 24 hrs  Measured after exposure in the room condition for 24hrs  Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes  Measured after exposure in the room condition for 24hrs  Test mode: Contact Discharge  Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative  Number of discharge: Discharge  Discharge level: ±12KV, ±16KV, ±25KV  Discharge interval: <5 seconds
2-1 2-2 2-3 2-4	Item High Temperature Exposure (Storage)  Low Temperature Exposure (Storage)  Operational Life  Biased Humidity  Temperature Cycling	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Duration of test: 12 cycles each of 3 orientations 20 minutes for each cycle Vibration axes: X, Y & Z  Test Method  Temperature: 150±3°C Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Temperature: -50±3°C Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Temperature: 125±2°C Appliend Current: Rated Current Time: 1000± 24 hrs  Measured after exposure in the room condition for 24hrs  Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs  Measured after exposure in the room condition for 24hrs  Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes  Measured after exposure in the room condition for 24hrs  Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative Number of discharge: Discharge Discharge level: ±12KV, ±16KV, ±25KV





#### Lead-Free(LF)標準溫度分析範圍

#### Refer to J-STD-020C

管制項目 Item.	升溫區 Ramp-up	預熱區 Pre-heating	迴焊區 Reflow	Peak Temp	冷卻區 Cooling
温度範圍 Temp.scope	R.T ~ 150℃	150℃ ~ 200℃	Above 217°C	260±5°C	Peak Temp.~150°C
標準時間 Time spec.	-	60 ~ 180 sec	60 ~ 150 sec	20 ~ 40 sec	-
實際時間 Time result	-	75 ~ 100 sec	90 ~ 120 sec	20 ~ 35 sec	-1

#### NOTE:

- 1.Re-flow possible times : within 3 times
- 2. Nitrogen adopted is recommendes while in re-flow
- 3. Products can only be soldered with reflow



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# 10 Packaging:

### 10.1 Packaging -Cover Tape

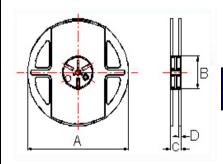
The force for tearing off cover tape is 10 to 100 grams in the arrow direction.



### 10.2 Packaging Quantity

TYPE	PCS/REEL
201212	2000

#### 10.3 Reel Dimensions



Dimensions in mm

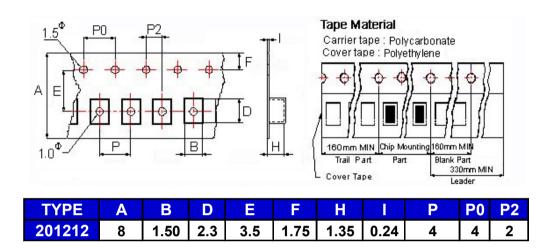
TYPE	Α	В	C	D
201212	178±1	60±0.5	12±0.5	1.5±0.5



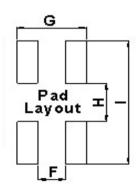
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# 10 Packaging:

#### 10.4 Tape Dimensions in mm



### 11 Recommended Land Pattern:



#### Dimensions in mm

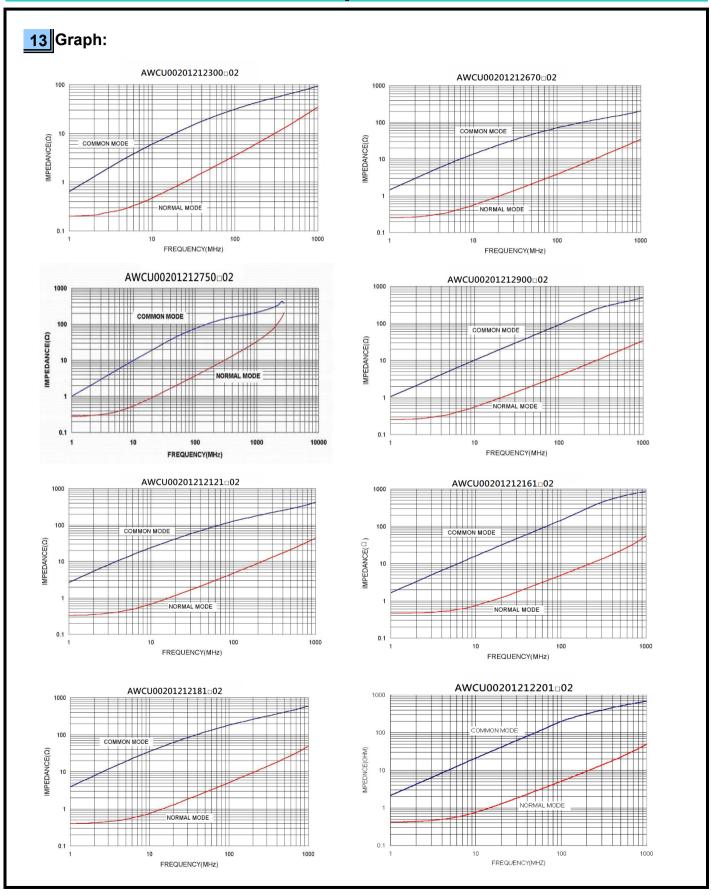
TYPE	F(In/mm)	G(In/mm)	H(In/mm)	l(ln/mm)
201212	0.016/0.4	0.05/1.27	0.04/1.1	0.10/2.6

### 12 Note:

- 1. Please make sure that your product has been evaluated and confirmed against your specifications when our product is mounted to your product.
- 2. Do not knock nor drop.
- 3. All the items and parameters in this product specification have been prescribed on the premise that our product is used for the purpose,under the condition and in the environment agreed upon between you and us. You are requested not to use our product deviating from such agreement.
- 4.The storage period is less than 12 months. Be sure to follow the storage conditions (Temperature: 5 to 40°C, Humidity: 10 to 75% RHor less).
  - If the storage period elapses, the soldering of the terminal electrodes may deteriorate.
- 5.Do not use or store in locations where there are conditions such as gas corrosion (salt, acid, alkali, etc.).
- 6. The moisture sensitivity level (MSL) of products is classified as level 1.

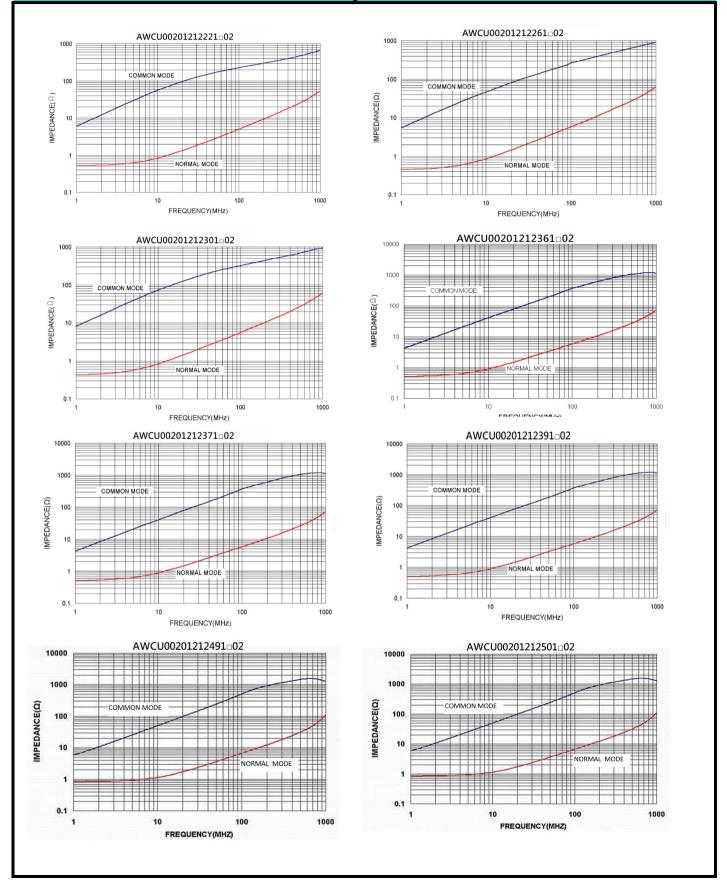








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